

LTC5577

300MHz to 6GHz High Signal Level Active Downconverting Mixer

DESCRIPTION

The LTC®5577 active mixer is optimized for RF downconverting applications that require high input signal handling capability and wide bandwidth. The wideband IF output uses external resistors to set the output impedance, allowing the flexibility to match directly into differential IF loads, such as filters and amplifiers. The part is characterized and specified with a 100 Ω differential output impedance, although it can be used with output impedances ranging from 50 Ω to 400 Ω , with higher gain and reduced IIP3 and P1dB at the higher impedance levels. The IF output is usable up to 1.5GHz.

In receiver applications, the high input P1dB and IIP3 allow the use of higher gain low noise amplifiers, resulting in higher receiver sensitivity. Integrated transformers on the RF and LO inputs provide single-ended 50Ω interfaces, while minimizing the solution size.

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FEATURES

- +30dBm IIP3
- +15dBm Input P1dB
- OdB Conversion Gain
- Wideband Differential IF Output
- Very Low 2 × 2 and 3 × 3 Spurs
- IF Frequency Range Up to 1.5GHz
- Low LO-RF Leakage
- LO Input 50Ω Matched when Shutdown
- –40°C to 105°C Operation (T_C)
- Very Small Solution Size
- 16-Lead (4mm × 4mm) QFN package

APPLICATIONS

- Wireless Infrastructure Receivers
- DPD Observation Receivers
- CATV Infrastructure

TYPICAL APPLICATION

Wideband Downconverting Mixer with 1GHz IF Bandwidth and +15 dBm Input P1dB into 100 Ω Load



Voltage Conversion Gain and IIP3 vs IF Output Frequency





(NOLE I)	
Supply Voltage (V _{CC} , IF ⁺ , IF ⁻)4.0)V
Enable Input Voltage (EN)0.3V to V _{CC} + 0.3	
LO Input Power (300MHz to 6GHz)+10dB	m
LO Input DC Voltage±0.1	۱V
RF Input Power (300MHz to 6GHz)+18dB	m
RF Input DC Voltage±0.1	۱V
TEMP Monitor Input Current10m	۱A
Operating Temperature Range (T _C)40°C to 105°	°C
Junction Temperature (T _J) 150°	°C
Storage Temperature Range65°C to 150°	°C

PIN CONFIGURATION



CAUTION: THIS PART IS SENSITIVE TO ELECTROSTATIC DISCHARGE (ESD). PROPER ESD HANDLING PRECAU-TIONS MUST BE OBSERVED.

ORDER INFORMATION

LEAD FREE FINISH	TAPE AND REEL	PART MARKING	PACKAGE DESCRIPTION	CASE TEMPERATURE RANGE
LTC5577IUF#PBF	LTC5577IUF#TRPBF	5577	16-Lead (4mm \times 4mm) Plastic QFN	-40°C to 105°C

Consult LTC Marketing for parts specified with wider operating temperature ranges.

Consult LTC Marketing for information on nonstandard lead based finish parts.

For more information on lead free part marking, go to: http://www.linear.com/leadfree/ For more information on tape and reel specifications, go to: http://www.linear.com/tapeandreel/

For more information on tape and reel specifications, go to: http://www.linear.com/tapeandreel/

AC ELECTRICAL CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_c = 25°C, V_{cc} = 3.3V, EN = High. Test circuit shown in Figure 1. (Notes 2, 3, 4)

PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
RF Input Frequency Range	External Matching Required		3	300 to 600	0	MHz
LO Input Frequency Range	External Matching Required	•	300 to 6000		MHz	
IF Output Frequency Range	External Matching Required	•		1 to 1500		MHz
RF Input Return Loss	Z ₀ = 50Ω, 1300MHz to 4300MHz, C3 = 8.2pF, C4 = 0.7pF			>10		dB
LO Input Return Loss	Z ₀ = 50Ω, 930MHz to 4000MHz, C5 = 3.9pF			>10		dB
IF+, IF ⁻ Output Return Loss	$Z_0 = 50\Omega$, 20MHz to 500MHz, L1, L2 = 560nH, R1, R2 = 115 Ω			>10		dB
LO Input Power			-6	0	6	dBm
RF to LO Isolation	RF = 300MHz to 2500MHz RF = 2500MHz to 4000MHz RF = 4000MHz to 6000MHz			>64 >50 >40		dB dB dB
RF to IF Isolation	RF = 300MHz to 6000MHz			>30		dB

AC ELECTRICAL CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_C = 25°C. V_{CC} = 3.3V, EN = High, P_{LO} = OdBm, IF = 153MHz, P_{RF} = -3dBm (-3dBm/ tone for 2-tone tests), unless otherwise noted. Test circuit shown in Figure 1. (Notes 2, 3, 4)

PARAMETER	CONDITIONS		MIN	ТҮР	MAX	UNITS
Power Conversion Gain	RF = 450MHz, High Side LO RF = 850MHz, High Side LO RF = 1900MHz, Low Side LO RF = 2550MHz, Low Side LO RF = 3500MHz, Low Side LO RF = 4900MHz, Low Side LO, IF = 900MHz RF = 5900MHz, Low Side LO, IF = 900MHz		-1.0	-0.5 0.5 0.7 0.5 0.2 0.1 -0.7		dB dB dB dB dB dB dB
Conversion Gain Flatness	RF = 1900 ±140MHz, L0 = 1747MHz, IF = 153 ±140MHz			±0.2		dB
Conversion Gain vs Temperature	$T_{C} = -40^{\circ}C$ to 105°C, RF = 1900MHz, Low Side LO	•		-0.013		dB/°C
2-Tone Input 3rd Order Intercept ($\Delta f_{RF} = 2MHz$)	RF = 450MHz, High Side LO RF = 850MHz, High Side LO RF = 1900MHz, Low Side LO RF = 2550MHz, Low Side LO RF = 3500MHz, Low Side LO RF = 4900MHz, Low Side LO, IF = 900MHz RF = 5900MHz, Low Side LO, IF = 900MHz			29.5 29.8 30.2 31.0 28.0 24.0 26.0		dBm dBm dBm dBm dBm dBm dBm
2-Tone Input 2nd Order Intercept (Δf_{RF} = 154MHz = f _{IM2})	RF = 450MHz (527MHz/373MHz), LO = 603MHz RF = 850MHz (927MHz/773MHz), LO = 1003MHz RF = 1900MHz (1977MHz/1823MHz), LO = 1747MHz RF = 2550MHz (2627MHz/2473MHz), LO = 2397MHz RF = 3500MHz (3577MHz/3423MHz), LO = 3347MHz			68 68 61 60 66		dBm dBm dBm dBm dBm
SSB Noise Figure	RF = 450MHz, High Side LO RF = 850MHz, High Side LO RF = 1900MHz, Low Side LO RF = 2550MHz, Low Side LO RF = 3500MHz, Low Side LO RF = 4900MHz, Low Side LO, IF = 900MHz RF = 5900MHz, Low Side LO, IF = 900MHz			13.4 11.7 11.8 12.5 14.3 15.2 15.0	14.0	dB dB dB dB dB dB dB
SSB Noise Figure Under Blocking	RF = 850MHz, High Side LO, 750MHz Blocker at 5dBm RF = 1900MHz, Low Side LO, 2000MHz Blocker at 5dBm			16.1 15.8		dB dB
1/2IF Output Spurious Product (f_{RF} Offset to Produce Spur at f_{IF} = 153MHz)	850MHz: f _{RF} = 926.5MHz at -3dBm, f _{L0} = 1003MHz 1900MHz: f _{RF} = 1823.5MHz at -3dBm, f _{L0} = 1747MHz			-85 -79		dBc dBc
1/3IF Output Spurious Product (f_{RF} Offset to Produce Spur at f_{IF} = 153MHz)	850MHz: f_{RF} = 952MHz at -3dBm, f_{LO} = 1003MHz 1900MHz: f_{RF} = 1798MHz at -3dBm, f_{LO} = 1747MHz			-86 -81		dBc dBc
Input 1dB Compression	$\begin{array}{l} RF=450MHz, High Side LO\\ RF=850MHz, High Side LO\\ RF=1900MHz, Low Side LO\\ RF=2550MHz, Low Side LO\\ RF=3500MHz, Low Side LO\\ RF=4900MHz, Low Side LO, IF=900MHz\\ RF=5900MHz, Low Side LO, IF=900MHz\\ \end{array}$			15.7 15.3 15.2 15.6 15.4 14.0 13.5		dBm dBm dBm dBm dBm dBm dBm
LO to RF Leakage	LO = 300MHz to 2500MHz LO = 2500MHz to 5200MHz LO = 5200MHz to 6000MHz			≤60 ≤50 ≤35		dBm dBm dBm
LO to IF Leakage	LO = 300MHz to 1800MHz LO = 1800MHz to 6000MHz			≤28 ≤33		dBm dBm



DC ELECTRICAL CHARACTERISTICS The \bullet denotes the specifications which apply over the full operating temperature range, otherwise specifications are at T_c = 25°C, V_{cc} = 3.3V, EN = High, unless otherwise noted. Test circuit shown in Figure 1. (Note 2)

PARAMETER		CONDITIONS		MIN	ТҮР	MAX	UNITS
Supply Voltage (V _{CC})			•	3.0	3.3	3.6	V
Supply Current	Enabled Disabled	EN = High EN = Low			180	217 200	mA μA
Enable Logic Input (E	N)		·				
Input High Voltage (Or	n)		•	2.5			V
Input Low Voltage (Of	f)		•			0.3	V
Input Current		-0.3V to V _{CC} + 0.3V		-60		200	μA
Turn-On Time					0.3		μs
Turn-Off Time					0.1		μs
Mixer DC Current Adj	ust (IADJ)		· · · ·				
Open-Circuit DC Volta	ge				2.2		V
Short-Circuit DC Curre	ent	Pin Shorted to Ground			3.6		mA
Temperature Sensing	Diode (TEMP)						
DC Voltage at T _J = 25°	°C	I _{IN} = 10μΑ I _{IN} = 80μΑ			716 773		mV mV
Voltage Temperature (Coefficient	I _{IN} = 10μΑ I _{IN} = 80μΑ	•		-1.75 -1.56		mV/°C mV/°C

Note 1: Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. Exposure to any Absolute Maximum Rating condition for extended periods may affect device reliability and lifetime.

Note 3: SSB Noise Figure measured with a small-signal noise source, bandpass filter and 2dB matching pad on RF input, and bandpass filter on the LO input.

Note 4: Specified performance excludes external 180° IF combiner loss.

Note 2: The LTC5577 is guaranteed functional over the -40°C to 105°C case temperature range ($\theta_{JC} = 8^{\circ}C/W$).

TYPICAL DC PERFORMANCE CHARACTERISTICS EN = High, Test circuit shown in Figure 1.



TEMP Diode Voltage vs Junction Temperature 900 850 TEMP DIODE VOLTAGE (mV) 800 $I_{IN} = 80 \mu A$ 750 700 $I_{IN} = 10 \mu A$ 650 600 550 500 -45 -20 5 30 55 80 105 130 JUNCTION TEMPERATURE (°C) 5577 G02



 $T_{\rm C} = -40^{\circ}{\rm C}$

 $T_{C} = 25^{\circ}C$

 $T_{C} = 85^{\circ}C$

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TYPICAL PERFORMANCE CHARACTERISTICS 1300MHz to 4300MHz application. Test circuit shown in Figure 1. V_{CC} = 3.3V, T_{C} = 25°C, P_{LO} = 0dBm, P_{RF} = -3dBm (-3dBm/tone for 2-tone IIP3 tests, Δf = 2MHz), IF = 153MHz, unless otherwise noted.

 $T_{\rm C} = -40^{\circ}{\rm C}$

 $\underline{T}_{C} = 25^{\circ}C$

 $T_{C} = 85^{\circ}C$

-



45 1.3 1.6

75

70

65

60

55

50

IIP2 (dBm)

2-Tone IIP2 vs RF Frequency $(\Delta f_{BF} = 154 MHz = f_{IM2})$ **RF Input P1dB vs RF Frequency** 18 17 16 15 14 P1dB (dBm) 13 12 11 10 9 8 1.9 2.2 2.5 2.8 3.1 3.4 3.7 4.0 4.3 1.9 2.2 2.5 2.8 3.1 3.4 3.7 4.0 4.3 1.3 1.6 **RF FREQUENCY (GHz) RF FREQUENCY (GHz)** 5577 G04

1900MHz Conversion Gain, IIP3 and NF vs LO Power



2550MHz Conversion Gain, IIP3 and NF vs LO Power



3500MHz Conversion Gain, IIP3 and NF vs LO Power



RF Isolation vs RF Frequency LO Leakage vs LO Frequency -20 -25 RF-LO -30 -35 -40 -0 LEAKAGE (dBm) -45 -50 -55 RF-IF -60 -65

3.7 4.0 4.3

5577 G09



LO-RF

-70

-75

-80

LO to Unbalanced IF Port Leakage vs LO Frequency



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1.3 1.6 1.9

 $2.2 \ 2.5 \ 2.8 \ 3.1 \ 3.4$

RF FREQUENCY (GHz)

70

65

60

55

50

45

40

35

30

25

ISOLATION (dB)

0.9 1.3 1.7 2.1 2.5 2.9 3.3 3.7 4.1 4.5 4.9

LO FREQUENCY (GHz)

5577 G10

TYPICAL PERFORMANCE CHARACTERISTICS 1300MHz to 4300MHz application. Test circuit shown in Figure 1. V_{CC} = 3.3V, T_{C} = 25°C, P_{LO} = 0dBm, P_{RF} = -3dBm (-3dBm/tone for 2-tone IIP3 tests, Δf = 2MHz), IF = 153MHz, unless otherwise noted.





TYPICAL PERFORMANCE CHARACTERISTICS 700MHz to 1000MHz application. Test circuit shown in Figure 1. V_{CC} = 3.3V, T_C = 25°C, P_{LO} = 0dBm, P_{RF} = -3dBm (-3dBm/tone for 2-tone IIP3 tests, Δf = 2MHz), IF = 153MHz, unless otherwise noted.

850MHz Conversion Gain,



RF Isolation and LO Leakage vs Frequency



2-Tone IF Output Power, IM3 and IM5 vs RF Input Power



IIP3 and NF vs LO Power 30 27 IIP3 24 SSB NF (dB) RF = 850MHz 21 HIGH SIDE LO 18 NF 15 IIP3 (dBm), 12 9 -40°C G_C (dB), [6 25°C GC 3 85°C 0 -3 6 -6 -4 -2 0 2 4 LO INPUT POWER (dBm) 5577 G22

850MHz Conversion Gain, IIP3 and NF vs Supply Voltage



Conversion Gain, IIP3, NF and RF Input P1dB vs Temperature



Single Tone IF Output Power, 2 × 2 and 3 × 3 Spurs vs RF Input Power



SSB Noise Figure vs RF Blocker Power



2 \times 2 and 3 \times 3 Spur Suppression vs LO Power





TYPICAL PERFORMANCE CHARACTERISTICS 375MHz to 525MHz application. Test circuit shown in Figure 1. V_{CC} = 3.3V, T_{C} = 25°C, P_{LO} = 0dBm, P_{RF} = -3dBm (-3dBm/tone for 2-tone IIP3 tests, Δf = 2MHz), IF = 153MHz, unless otherwise noted.





4.9GHz and 5.9GHz applications. IF = 900MHz, Low Side LO, P_{LO} = 0dBm. Test circuit shown in Figure 1.





PIN FUNCTIONS

GND (Pins 1, 4, 9, 13, 16, Exposed Pad Pin 17): Ground. These pins must be soldered to the RF ground plane on the circuit board. The exposed pad metal of the package provides both electrical contact to ground and good thermal contact to the printed circuit board.

RF (Pin 2): Single-Ended RF Input. This pin is internally connected to the primary winding of the integrated RF transformer, which has low DC resistance to ground. **A series DC-blocking capacitor must be used if the RF source has DC voltage present.** The RF input is 50Ω impedance matched, using the matching element values shown in Figure 1, when the mixer is enabled.

NC (Pins 3, 11): These pins are not connected internally. They can be left floating, connected to ground, or to V_{CC} .

EN (Pin 5): Enable Pin. When the input voltage is greater than 2.5V, the mixer is enabled. When the input voltage is less than 0.3V, the mixer is disabled. Typical input current is less than 30μ A. This pin has an internal pull-down resistor.

 V_{CC} (Pins 6, 7): Power Supply Pins. These pins must be connected to a regulated 3.3V supply, with a bypass capacitor located close to the pin. Typical DC current consumption is 68mA.

IADJ (Pin 8): Mixer Core Current Adjust Pin. Connecting a resistor between this pin and ground will reduce the mixer core DC supply current. Typical open-circuit DC voltage is 2.2V. This pin should be left floating for optimum performance.

LO (Pin 10): Single-Ended Local Oscillator Input. This pin is internally connected to the primary winding of an integrated transformer, which has low DC resistance to ground. **A series DC-blocking capacitor must be used to avoid damage to the internal transformer.** This input is 50Ω impedance matched from 930MHz to 4GHz, even when the IC is disabled. Operation down to 300MHz or up to 6GHz is possible with the external matching shown in Figure 1.

TEMP (Pin 12): Temperature Sensing Diode. This pin is connected to the anode of a diode that may be used to measure the die temperature, by forcing a current and measuring the voltage.

IF⁺/**IF**⁻ (**Pin 15/Pin 14**): Open-Collector Differential IF Output. These pins must be connected to the V_{CC} supply through impedance-matching inductors or a transformer center tap. Typical DC current consumption is 56mA into each pin.

BLOCK DIAGRAM





TEST CIRCUIT



APPLICAT	ION		RF MATCH		LO MATCH		IF MATCH
RF (MHz)	LO	C3	C4	L3	C5	C6	L1, L2
300 to 400	HS	330pF	18pF	2.2nH	47pF	15pF	560nH
375 to 525	HS	330pF	15pF	2nH	27pF	8.2pF	560nH
700 to 1000	HS	330pF	6pF	_	6.8pF	2.7pF	560nH
1300 to 4300	LS, HS	8.2pF	0.7pF	_	3.9pF	_	560nH
4900	LS	1.8nH (L)	0.7pF	_	1pF	_	10nH*
5900	LS	0.25pF	_	_	1pF	—	10nH*

LS = Low side, HS = High side. *IF = 900MHz

REF DES	VALUE	SIZE	VENDOR
C1, C2, C7, C8	1nF	0402	Murata
C3 - C6	See Table	0402	Murata
R1, R2	115Ω, 1%	0402	
C9	1µF	0603	AVX
L1, L2	See Table	0603	Coilcraft 0603LS
L3	See Table	0402	Coilcraft 0402HP

Figure 1. Standard Downmixer Test Circuit Schematic (Wideband 100 Ω Differential IF Output)



Introduction

The LTC5577 incorporates a high linearity double-balanced active mixer, a high-speed limiting LO buffer and bias/ enable circuits. See the Pin Functions and Block Diagram sections for a description of each pin. A test circuit schematic showing all external components required for the data sheet specified performance is shown in Figure 1. A few additional components may be used to modify the DC supply current or frequency response, which will be discussed in the following sections.

The LO and RF inputs are single ended. The test circuit, shown in Figure 1, is configured with a 100Ω differential IF output. An external broadband 180° passive combiner is used to combine the differential IF outputs to 50Ω single-ended for characterization and test purposes. The evaluation board layout is shown in Figure 2.

RF Input

A simplified schematic of the mixer's RF input is shown in Figure 3. As shown, one terminal of the integrated RF transformer's primary winding is connected to Pin 2, while the other terminal is DC-grounded internally. For this reason, a series DC-blocking capacitor (C3) is needed if the RF source has DC voltage present. The DC resistance of the primary winding is approximately 3Ω . The secondary winding of the RF transformer is internally connected to the RF buffer amplifier.

ESD protection diodes are not used on the RF input due to the high RF voltage swing associated with the LTC5577's high IIP3 and input P1dB. The internal RF transformer provides some protection for the RF matching capacitor against human-body model ESD strikes up to 3kV. Proper ESD handling techniques must be employed to avoid damaging this capacitor.



Figure 3. RF Input Schematic



Figure 2. Evaluation Board Layout



The RF input is 50Ω matched from 1300MHz to 4300MHz using C3 = 8.2pF and C4 = 0.7pF. Matching to RF frequencies above or below this frequency range is easily accomplished by using the the element values shown in Figure 1. For RF frequencies below 500MHz, series inductor L3 is also needed. The evaluation board does not have provisions for L3, so the RF input trace needs to be cut to install it in series. Measured RF input return losses are shown in Figure 4. The RF input impedance and input reflection coefficient, versus frequency are listed in Table 1.

Table 1. RF Input Impedance and S11 (at Pin 2, No External Matching, Mixer Enabled)

REQUENCY	INPUT	S	511
(MHz)	IMPEDANCE	MAG	ANGLE
200	4.4 + j8.5	0.84	163
350	6.6 + j12.0	0.78	153
450	8.3 + j14.4	0.74	147
575	10.1 + j17.2	0.69	141
700	12.0 + j19.9	0.66	136
900	15.4 + j22.8	0.60	127
1100	18.9 + j25.9	0.55	120
1400	25.2 + j29.5	0.48	109
1700	33.2 + j30.9	0.40	98
1950	40.0 + j29.1	0.33	91
2200	45.2 + j24.3	0.25	87
2450	47.1 + j18.0	0.18	89
2700	44.7 + j12.8	0.15	105
3000	39.1 + j10.7	0.17	129
3300	33.0 + j13.8	0.26	132
3600	28.4 + j20.1	0.36	123
3900	25.2 + j29.1	0.48	109
4200	23.5 + j39.1	0.57	95
4500	22.8 + j52.1	0.66	82
4800	23.6 + j66.1	0.72	70
5400	28.6 + j98.2	0.80	51
6000	38.0 + j134.4	0.84	38



Figure 4. RF Input Return Loss

LO Input

A simplified schematic of the LO input, with external components is shown in Figure 5. Similar to the RF input, the integrated LO transformer's primary winding is DC-grounded internally, and therefore requires an external DC-blocking capacitor. Capacitor C5 provides the necessary DC-blocking, and optimizes the LO input match over the 930MHz to 4GHz frequency range. The nominal LO input level is OdBm although the limiting amplifiers will deliver excellent performance over a \pm 6dB input power range. LO input power greater than +6dBm may cause conduction of the internal ESD diodes.



Figure 5. LO Input Schematic



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To optimize the LO input match for frequencies below 1GHz, the value of C5 is increased and shunt capacitor C6 is added. A summary of values for C5 and C6, versus LO frequency range is listed in Table 2. Measured LO input return losses are shown in Figure 6. Finally, LO input impedance and input reflection coefficient, versus frequency is shown in Table 3.

C5 (pF)	C6 (pF)					
330	33					
330	22					
56	18					
27	8.2					
15	7.5					
6.8	2.7					
3.9	—					
1.0	—					
	C5 (pF) 330 330 56 27 15 6.8 3.9					

The LO buffers have been designed such that the LO input impedance does not change significantly when the IC is disabled. This feature only requires that supply voltage is applied. The actual performance of this feature is shown in Figure 7. As shown, the LO input return loss is better than 10dB over the 1GHz to 4GHz frequency range when the IC is enabled or disabled.



Figure 6. LO Input Return Loss

FREQUENCY	INPUT	S	11
(MHz)	IMPEDANCE	MAG	ANGLE
350	5.2 + j14.9	0.83	146.5
400	6.0 + j17.3	0.81	141.7
450	6.6 + j19.5	0.80	137.0
500	7.2 + j21.5	0.78	132.7
600	9.1 + j26.5	0.75	123.6
800	15.1 + j35.7	0.67	106.0
1000	24.9 + j43.6	0.58	89.5
1500	67.5 + j36.4	0.33	47.1
2000	61.7 – j4.2	0.11	-18.3
2500	40.3 – j7.1	0.13	-139.4
3000	31.7 + j1.8	0.23	173.1
3500	29.8 + j12.3	0.29	140.0
4000	31.5 + j22.9	0.35	113.2
4500	36.0 + j32.4	0.38	92.8
5000	59.0 + j40.6	0.36	57.1
5500	64.2 + j30.8	0.29	50.1
6000	57.4 + j19.7	0.19	59.0

Table 3. LO Input Impedance and S11 (at Pin 10, No External



Figure 7. LO Input Return Loss—Mixer Enabled and Disabled



IF Output

The IF output schematic with external matching components is shown in Figure 8. As shown, the output is differential open collector. Each IF output pin must be biased at the supply voltage (V_{CC}), which is applied through the external matching inductors (L1 and L2) shown in Figure 8. Each pin draws approximately 56mA of DC supply current (112mA total). Inductors with less than 1 Ω DC resistance, such as Coilcraft 0603LS, are required for the highest IIP3 and P1dB.

The differential IF output impedance can be modeled as a frequency-dependent parallel R-C circuit, using the values listed in Table 4. This data is referenced to the package pins (with no external components) and includes the effects of the IC and package parasitics. Resistors R1 and R2 are used to reduce the output resistance, which increases the IF bandwidth and input P1dB, but reduces the conversion gain.

100 Ω Differential IF Output Matching

The standard downmixer test circuit shown in Figure 1 uses 115Ω resistors to realize a 100Ω differential output. 560nH pull-up inductors are used to deliver a broadband IF output from 10MHz to greater than 600MHz. C7 and C8 are 1nF DC-blocking capacitors.



Figure 8. IF Output Schematic with External Matching

To match the IF output for frequencies greater than 600MHz, the values of L1 and L2 are selected to resonate with the internal IF capacitance ($C_{\rm IF}$) at the desired IF center frequency, using the following equation:

L1, L2=
$$\frac{1}{(2 \cdot \pi \cdot f_{IF})^2 \cdot 2 \cdot C_{IF}}$$

Table 4 summarizes the optimum IF matching element values, versus IF center frequency, to be used in the standard downmixer test circuit shown in Figure 1. The inductor values are slightly less than the ideal calculated values due to the additional capacitance of the evaluation board traces. Measured differential IF output return losses are shown in Figure 9.

Table 4. IF Output Impedance and Bandpass Matching Element Values vs IF Frequency.	t
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IF FREQUENCY	DIFFERENTIAL IF OUTPUT IMPEDANCE	ELEMENT	MATCHING [values ntial output)
(MHz)	(R _{IF} C _{IF})	L1, L2	R1, R2
10-600	390Ω 1.55pF	560nH	115Ω
450	390Ω 1.55pF	39nH	115Ω
800	367Ω 1.68pF	10nH	115Ω
1000	343Ω 1.73pF	6nH	133Ω
1200	317Ω 1.81pF	3.3nH	191Ω
1400	261Ω 1.91pF		
1600	212Ω 2.02pF		
1800	156Ω 2.19pF		
2000	105Ω 2.43pF		



Figure 9. Differential IF Output Return Loss— 100Ω Differential Load

Wideband 50 Ω Single-Ended IF Output Matching

For applications that require a 50Ω single-ended IF output, a 2:1 transformer can be added to the 100Ω differential output as shown in Figure 10. Recommended transformers include the Mini-Circuits TC2-1T+, or Coilcraft WBC2-1T. No other IF matching element changes are required.



Figure 10. 50 Ω Single-Ended IF Output

Measured conversion gain and IIP3 using a Mini-Circuits TC2-1T+ (2:1) IF transformer are shown in Figure 11, with the measured performance of the standard 100Ω differential output for comparison. As shown, the single-ended conversion gain is about 0.5dB less up to 700MHz due to the transformer loss. Above 700MHz, the IF transformer loss increases rapidly. Up to 600MHz, both solutions have similar IIP3. Above 600MHz, the transformer version has about 1dB lower IIP3.



Figure 11. Conversion Gain and IIP3 vs IF Output Frequency. 50 Ω Single-Ended Output Using a Transformer vs 100 Ω Differential Output



Mixer Bias Current Reduction

The IADJ pin (Pin 8) is available for reducing the mixer core DC current consumption at the expense of linearity and P1dB. For the highest performance, this pin should be left floating. As shown in Figure 12, an internal bias circuit produces a 6mA reference current for the mixer core. If a resistor is connected to Pin 8, as shown in Figure 12, a portion of the reference current can be shunted to ground, resulting in reduced mixer core current. For example, R3 = 220Ω will shunt away 3mA from Pin 8 and reduce the mixer core current by 50%. The nominal, open-circuit DC voltage at the IADJ pin is 2.2V. Table 5 lists DC supply current and RF performance at 1900MHz for various values of R3.

R3 (Ω)	I _{CC} (mA)	G _C (dB)	IIP3 (dBm)	P1dB (dBm)	NF (dB)
Open	180	0.7	30.2	15.2	11.8
2k	166	0.6	28.0	15.0	11.1
1k	156	0.5	26.7	14.8	10.9
220	133	0.2	23.9	13.4	10.4
120	125	0.0	22.3	12.4	10.3
75	122	0.0	22.0	12.0	10.3

Table 5. Mixer Performance with Reduced Current (RF = 1900MHz, Low Side LO, IF = 153MHz)



Figure 12. IADJ Interface



Enable Interface

Figure 13 shows a simplified schematic of the enable interface. To enable the mixer, the EN voltage must be higher than 2.5V. If the enable function is not required, the pin should be connected directly to V_{CC} . The voltage at the EN pin should never exceed the power supply voltage (V_{CC}) by more than 0.3V. If this should occur, the supply current could be sourced through the ESD diode, potentially damaging the IC.

The EN pin has an internal 300k pull-down resistor. Therefore, the mixer will be disabled with the enable pin left floating.

Supply Voltage Ramping

Fast ramping of the supply voltage can cause a current glitch in the internal ESD clamp circuits connected to the V_{CC} pin. Depending on the supply inductance, this could result in a supply voltage transient that exceeds the 4.0V maximum rating. A supply voltage ramp time greater than 1ms is recommended.



Figure 13. Enable Input Circuit

Spurious Output Levels

Mixer spurious output levels versus harmonics of the RF and LO are tabulated in Table 6. The spur levels were measured on a standard evaluation board using the test circuit shown in Figure 1. Table 6a shows the relative spur levels with an RF input power level of –3dBm while Table 6b shows the same relative spur levels with the RF input power reduced to –6dBm.

The spur frequencies can be calculated using the following equation:

$$f_{SPUR} = (M \bullet f_{RF}) - (N \bullet f_{LO})$$

Table 6. IF Output Spur Levels (dBc). RF = 1900MHz, IF = 153MHz, Low Side LO, P_{LO} = 0dBm, V_{CC} = 3.3V, T_C = 25°C Table 6a. P_{BF} = -3dBm

N										
		0	1	2	3	4	5	6	7	8
	0		-25	-35	-35	-39	-55	-35	-58	-55
	1	-34	0	-34	-18	-46	-41	-71	-53	-72
	2	-72	-59	-70	-65	-81	*	-81	*	-76
М	3	*	-70	*	-79	*	-86	*	-83	*
	4	-88	*	-90	*	*	*	*	*	*
	5	*	*	*	*	*	*	*	*	*
	6	*	-88	*	*	*	*	*	*	*
	7	*	-88	*	*	*	*	*	*	*

*Less than -90dBc

	N									
		0	1	2	3	4	5	6	7	8
	0		-22	-31	-18	-36	-41	-32	-55	-51
	1	-34	0	-34	-68	-46	-86	-71	-53	-73
	2	-76	-62	-73	-84	-84	*	-85	*	-80
Μ	3	-87	-76	*	*	*	*	*	*	*
	4	*	*	-87	*	*	*	*	*	*
	5	*	-87	*	*	*	*	*	*	*
	6	*	*	*	*	*	*	*	*	*
	7	*	-86	*	*	*	*	*	*	*
			-							

*Less than -90dBc



TYPICAL APPLICATIONS

100Ω DIFFERENTIAL LOAD 50Ω 50Ω ٨٨ ÷ IF $50\overline{\Omega}$ 50Ω C7 C8 1nF 1nF L1 560nH L2 560nH R1 115Ω R2 115Ω Ŵ - C2 1nF Ŧ ÷ 16 15 14 13 GND IF GND TEMP 12 C3 3.9pF LTC5577 RF_{IN} 700MHz TO 4GHz • NC 11 2 RF **-** C4 **E** L4 9.5nH 17 GND I C3 Ŧ 1pF 2.7pF LO_{IN} 820MHz TO 4.3GHz LO 10 • 4 GND GND 9 Ē V_{CC} IADJ V_{CC} FN 8 6 5 V_{CC} 3.3V ΕN · C1 **-** C9 DC2070A <u></u>Ξ^{1μF} EVAL BOARD 5577 TA02a









PACKAGE DESCRIPTION

Please refer to http://www.linear.com/designtools/packaging/ for the most recent package drawings.



UF Package

- ALL DIMENSIONS ARE IN MILLIMETERS
 AL DIMENSIONS OF EXPOSED PAD ON BOTTOM OF PACKAGE DO NOT INCLUDE
- MOLD FLASH. MOLD FLASH, IF PRESENT, SHALL NOT EXCEED 0.15mm ON ANY SIDE
- 5. EXPOSED PAD SHALL BE SOLDER PLATED
- 6. SHADED AREA IS ONLY A REFERENCE FOR PIN 1 LOCATION ON THE TOP AND BOTTOM OF PACKAGE



TYPICAL APPLICATION

Measured Performance Using 50 $\Omega,$ 100 $\Omega,$ 200 Ω and 400 Ω Differential IF Output Impedance



RF = 1900MHz, IF = 153MHz, Low Side LO, P_{L0} = 0dBm, T_{C} = 25°C

				r	-	
Z _{IF} (DIFF)	R1, R2	T1 (RATIO)	G _C (dB)	IIP3 (dBm)	Input P1dB (dBm)	10dB IF Return Loss BW (MHz)
50Ω	53.6Ω	TC1-1+ (1:1)	-2.8	30.9	17.0	9-855
100Ω	115Ω	TC2-1T+ (2:1)	0.2	30.1	15.2	20-636
200Ω	249Ω	TC4-1W+ (4:1)	2.2	29.6	12.2	35-300
400Ω	Open	TC8-1+ (8:1)	4.0	27.4	8.1	54-193

Measured performance includes IF transformer loss

RELATED PARTS

PART NUMBER	DESCRIPTION	COMMENTS				
Infrastructure						
LTC5567	400MHz to 4GHz, Active Downconverting Mixer	1.9dB Gain, 26.9dBm IIP3 and 11.8dB NF at 1950MHz, 3.3V/89mA Supply				
LTC5510	1MHz to 6GHz Wideband High Linearity Active Mixer	1.5dB Gain, Up- and Downconversion, 3.3V or 5V Supply				
LTC5551	300MHz to 3.5GHz Ultrahigh Dynamic Range Downconverting Mixer	2.4dB Gain, 36dBm IIP3, <10dB NF, 3.3V/204mA Supply				
LTC559x	600MHz to 4.5GHz Dual Downconverting Mixer Family	8.5dB Gain, 26.5dBm IIP3, 9.9dB NF, 3.3V/380mA Supply				
LTC5569	300MHz to 4GHz, 3.3V Dual Active Downconverting Mixer	2dB Gain, 26.8dBm IIP3 and 11.7dB NF, 3.3V/180mA Supply				
LTC5541	600MHz to 4GHz, 5V Downconverting Mixer Family	8dB Gain, >25dBm IIP3 and 10dB NF, 3.3V/200mA Supply				
LTC6400-X	300MHz Low Distortion IF Amp/ADC Driver	Fixed Gain of 8dB, 14dB, 20dB and 26dB; >36dBm OIP3 at 300MHz, Differential I/O				
LTC6412	31dB Linear Analog VGA	35dBm OIP3 at 240MHz, Continuous Gain Range –14dB to 17dB				
LT5554	Ultralow Distort IF Digital VGA	48dBm OIP3 at 200MHz, 2dB to 18dB Gain Range, 0.125dB Gain Steps				
LTC6430-15	High Linearity Differential IF Amplifier	50dBm OIP3 at 240MHz, 15dB Gain, 3dB NF				
LTC6431-15	High Linearity 50 Ω Gain Block	$47 dBm$ OIP3 at 240MHz, NF = 3.3dB, 15.5dB Gain, Single-Ended 50 Ω Input and Output Ports				
RF Power Deter	ctors					
LT5538	40MHz to 3.8GHz Log Detector	±0.8dB Accuracy Over Temperature, –72dBm Sensitivity, 75dB Dynamic Range				
LT5581	6GHz Low Power RMS Detector	40dB Dynamic Range, ±1dB Accuracy Over Temperature, 1.5mA Supply Current				
LTC5582	40MHz to 10GHz RMS Detector	±0.5dB Accuracy Over Temperature, ±0.2dB Linearity Error, 57dB Dynamic Range				
LTC5583	Dual 6GHz RMS Power Detector	Up to 60dB Dynamic Range, ±0.5dB Accuracy Over Temperature, >50dB Isolation				
ADCs	·	·				
LTC2208	16-Bit, 130Msps ADC	78dBFS Noise Floor, >83dB SFDR at 250MHz				
LTC2153-14	14-Bit, 310Msps Low Power ADC	68.8dBFS SNR, 88dB SFDR, 401mW Power Consumption				

